

Application/Control No.	1
10/697 220	1

Applicant(s)/Patent under Reexamination
CREAMER ET AL.
Art Unit

Examiner

Quynh H. Nguyen

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	SEAR	CHED	
Class	Subclass	Date	Examiner
348	14.08 14.09	7/5/2005	QN
370	261	7/5/2005	QN
379	202.01	7/5/2005	QN
379	203.01	7/5/2005	QN
379	204.01	7/5/2005	QN
379	205.01	7/5/2005	QN
379	206.01	7/5/2005	QN
709	204	7/5/2005	QN
715	753	7/5/2005	QN
above	updated	12/20/05	QN
above	updated	7/10/06	QN

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
379	202.01 203.01 204.01 205.01 206.01	7/12/06	QN
348	14.08 14.09	7/12/06	QN
370 709 715	261 204 753	7/12/06	QN
	ce searched printout	7/12/06	QN

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
searched: east, USPGPub, USPAT	7/5/2005	QN
nventor searched through PALM database	7/5/2005	QN
Consulted with Benny Tieu (Primary class 379)	7/10/06	QN